

4.5Ω, High Speed, Low Voltage Quad, SPDT Analog Switch

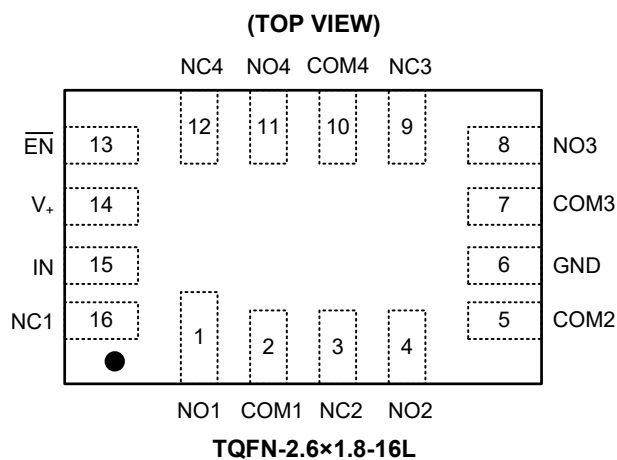
MODEL	PACKAGE DESCRIPTION	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKING OPTION
SGM44603	TQFN-2.6×1.8-16L	-40°C to +85°C	SGM44603YTQA16/TR	44603 XXXXX	Tape and Reel, 3000

Diagram illustrating the structure of the 10-digit part number:

- Vendor Code (3 digits)
- Date Code - Week (2 digits)
- Date Code - Year (5 digits)

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PIN CONFIGURATION



PIN DESCRIPTION

NAME	PIN	FUNCTION
V ₊	14	Power Supply.
GND	6	Ground.
IN	15	Digital Control Pin to Connect the COM Terminal to the NO or NC Terminals.
$\overline{\text{EN}}$	13	Digital Enable Input. Normally connect to GND. Drive to logic high to set all switches off.
COM _x	2, 5, 7, 10	Common Terminal.
NO _x	1, 4, 8, 11	Normally-Open Terminal.
NC _x	16, 3, 9, 12	Normally-Closed Terminal.

NOTE: NO_x, NC_x and COM_x terminals may be an input or output.

FUNCTION TABLE

$\overline{\text{EN}}$	IN	NO	NC
L	L	OFF	ON
L	H	ON	OFF
H	√	All Switches Open	

√ = Don't Care.

ELECTRICAL CHARACTERISTICS

($V_+ = +4.5V$ to $+5.5V$, $GND = 0V$, $V_{IH} = +1.6V$, $V_{IL} = +0.5V$, Full = $-40^\circ C$ to $+85^\circ C$. Typical values are at $V_+ = +5.0V$, $T_A = +25^\circ C$, unless otherwise noted.)

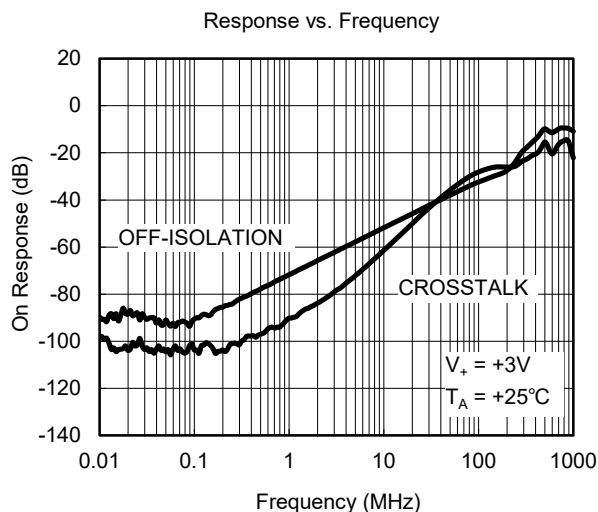
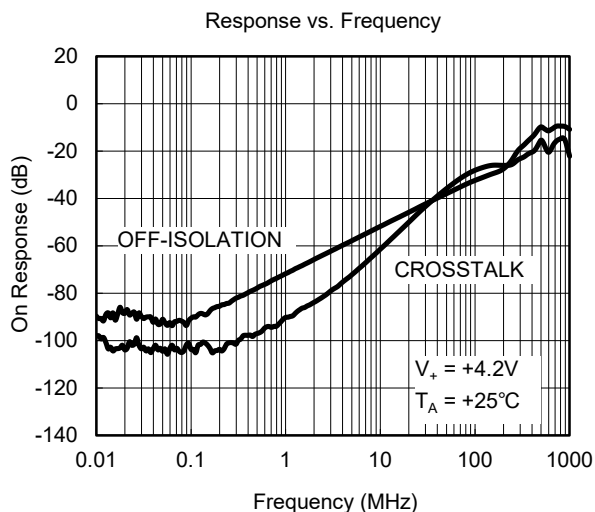
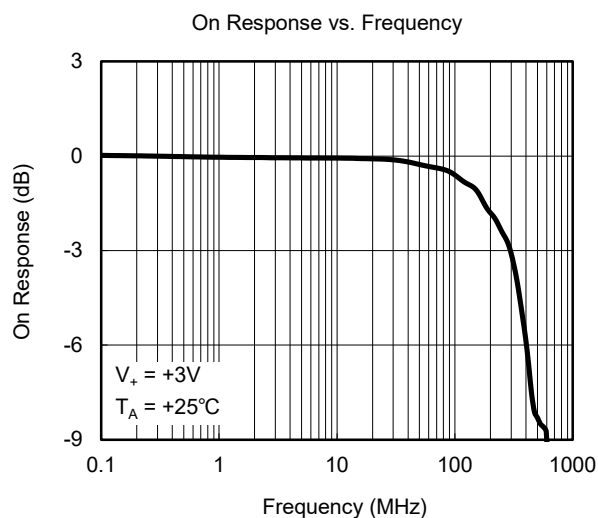
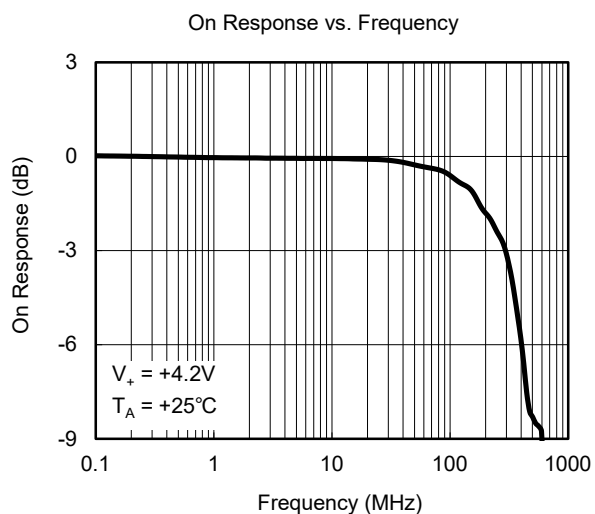
PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP	MAX	UNITS
Analog Switch							
Analog Signal Range	V_{NO}, V_{NC}, V_{COM}		Full	0		V_+	V
On-Resistance	R_{ON}	$V_+ = 4.5V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		4.5	7	Ω
			Full			8	
On-Resistance Match between Channels	ΔR_{ON}	$V_+ = 4.5V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		0.8	3.6	Ω
			Full			4.2	
On-Resistance Flatness	$R_{FLAT(ON)}$	$V_+ = 4.5V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		3	3.7	Ω
			Full			4.5	
Source Off Leakage Current	$I_{NC(OFF)}, I_{NO(OFF)}$	$V_+ = 5.5V, V_{NO} \text{ or } V_{NC} = 3.3V/0.3V, V_{COM} = 0.3V/3.3V$	Full			1	μA
Channel On Leakage Current	$I_{NC(ON)}, I_{NO(ON)}, I_{COM(ON)}$	$V_+ = 5.5V, V_{COM} = 0.3V/3.3V, V_{NO} \text{ or } V_{NC} = 0.3V/3.3V \text{ or floating}$	Full			1	μA
Digital Inputs							
Input High Voltage	V_{INH}		Full	1.6			V
Input Low Voltage	V_{INL}		Full			0.5	V
Input Leakage Current	I_{IN}	$V_+ = 5.5V, V_{IN}, V_{EN} = 0V \text{ or } V_+$	Full			1	μA
Dynamic Characteristics							
Turn-On Time	t_{ON}	$V_{NO} \text{ or } V_{NC} = 3V, C_L = 35pF, R_L = 300\Omega$, Test Circuit 2	$+25^\circ C$		40		ns
Turn-Off Time	t_{OFF}		$+25^\circ C$		30		ns
Charge Injection Select Input to Common I/O	Q	$V_G = GND, R_G = 0\Omega, C_L = 1nF, Q = C_L \times V_{OUT}$, Test Circuit 3	$+25^\circ C$		20		pC
Break-Before-Make Time Delay	t_D	$V_{NO} \text{ or } V_{NC} = 3V, R_L = 300\Omega, C_L = 35pF$, Test Circuit 4	$+25^\circ C$		18		ns
Off Isolation	O_{ISO}	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 5	1MHz $+25^\circ C$		-70		dB
			10MHz $+25^\circ C$		-50		
Channel-to-Channel Crosstalk	X_{TALK}	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 6	1MHz $+25^\circ C$		-90		dB
			10MHz $+25^\circ C$		-60		
-3dB Bandwidth	BW	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 7	$+25^\circ C$		300		MHz
Channel On Capacitance	C_{ON}		$+25^\circ C$		64		pF
Power Requirements							
Power Supply Range	V_+		Full	1.8		5.5	V
Power Supply Current	I_+	$V_+ = 5.5V, V_S, V_{EN} = 0V \text{ or } V_+$	Full			1	μA

ELECTRICAL CHARACTERISTICS (continued)

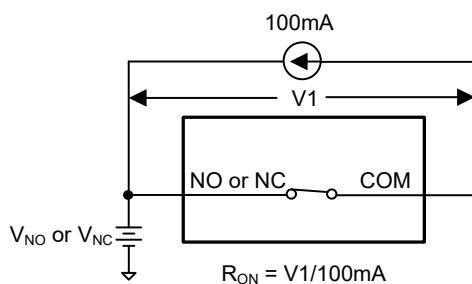
($V_+ = +2.7V$ to $+3.6V$, $V_{IH} = +1.6V$, $V_{IL} = +0.4V$, Full = $-40^\circ C$ to $+85^\circ C$. Typical values are at $V_+ = +3.0V$, $T_A = +25^\circ C$, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP	MAX	UNITS
Analog Switch							
Analog Signal Range	V_{NO}, V_{NC}, V_{COM}		Full	0		V_+	V
On-Resistance	R_{ON}	$V_+ = 2.7V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		11	15.5	Ω
			Full			18.5	
On-Resistance Match between Channels	ΔR_{ON}	$V_+ = 2.7V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		1.6	4	Ω
			Full			4.6	
On-Resistance Flatness	$R_{FLAT(ON)}$	$V_+ = 2.7V, 0V \leq V_{NO} \text{ or } V_{NC} \leq V_+, I_{COM} = -100mA$, Test Circuit 1	$+25^\circ C$		7	9.4	Ω
			Full			13	
Source Off Leakage Current	$I_{NC(OFF)}, I_{NO(OFF)}$	$V_+ = 3.6V, V_{NO} \text{ or } V_{NC} = 3.3V/0.3V, V_{COM} = 0.3V/3.3V$	Full			1	μA
Channel On Leakage Current	$I_{NC(ON)}, I_{NO(ON)}, I_{COM(ON)}$	$V_+ = 3.6V, V_{COM} = 0.3V/3.3V, V_{NO} \text{ or } V_{NC} = 0.3V/3.3V \text{ or floating}$	Full			1	μA
Digital Inputs							
Input High Voltage	V_{INH}		Full	1.5			V
Input Low Voltage	V_{INL}		Full			0.4	V
Input Leakage Current	I_{IN}	$V_+ = 2.7V, V_{IN}, V_{EN} = 0V \text{ or } V_+$	Full			1	μA
Dynamic Characteristics							
Turn-On Time	t_{ON}	$V_{NO} \text{ or } V_{NC} = 1.5V, C_L = 35pF, R_L = 300\Omega$, Test Circuit 2	$+25^\circ C$		48		ns
Turn-Off Time	t_{OFF}		$+25^\circ C$		45		ns
Charge Injection Select Input to Common I/O	Q	$V_G = GND, R_G = 0\Omega, C_L = 1nF, Q = C_L \times V_{OUT}$, Test Circuit 3	$+25^\circ C$		20		pC
Break-Before-Make Time Delay	t_D	$V_{NO} \text{ or } V_{NC} = 1.5V, R_L = 300\Omega, C_L = 35pF$, Test Circuit 4	$+25^\circ C$		20		ns
Off Isolation	O_{ISO}	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 5	1MHz $+25^\circ C$		-70		dB
			10MHz $+25^\circ C$		-50		
Channel-to-Channel Crosstalk	X_{TALK}	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 6	1MHz $+25^\circ C$		-90		dB
			10MHz $+25^\circ C$		-60		
-3dB Bandwidth	BW	$R_L = 50\Omega$, Signal = 0dBm, Test Circuit 7	$+25^\circ C$		300		MHz
Channel On Capacitance	C_{ON}		$+25^\circ C$		64		pF

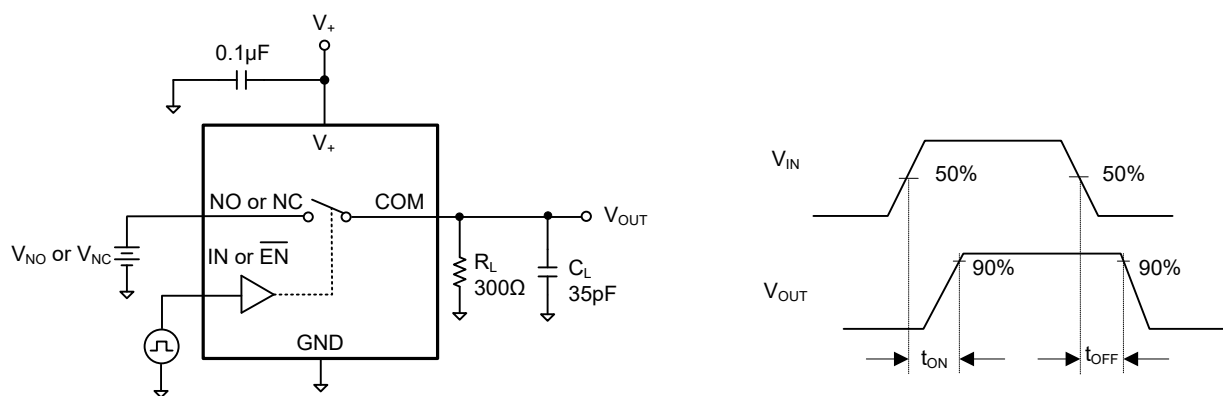
TYPICAL PERFORMANCE CHARACTERISTICS



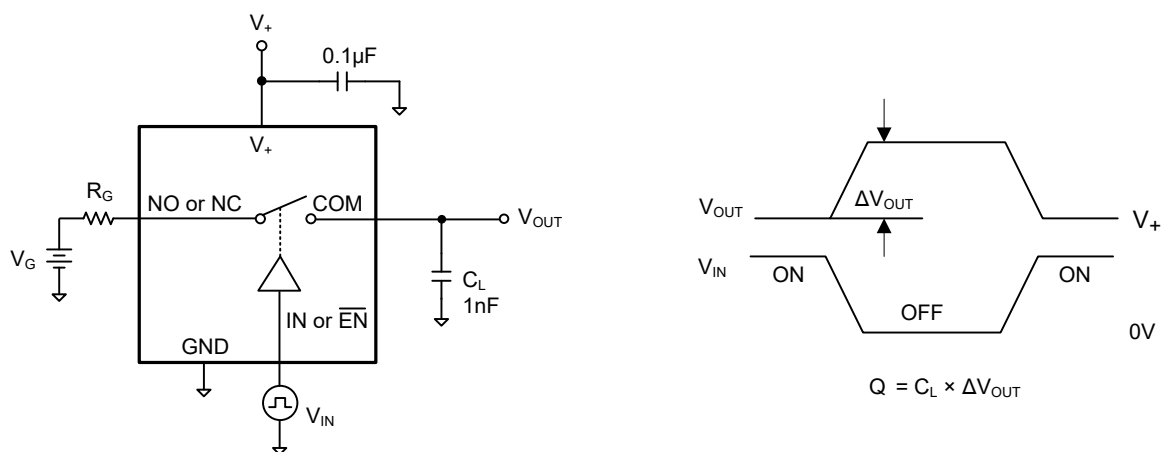
TEST CIRCUITS



Test Circuit 1. On-Resistance

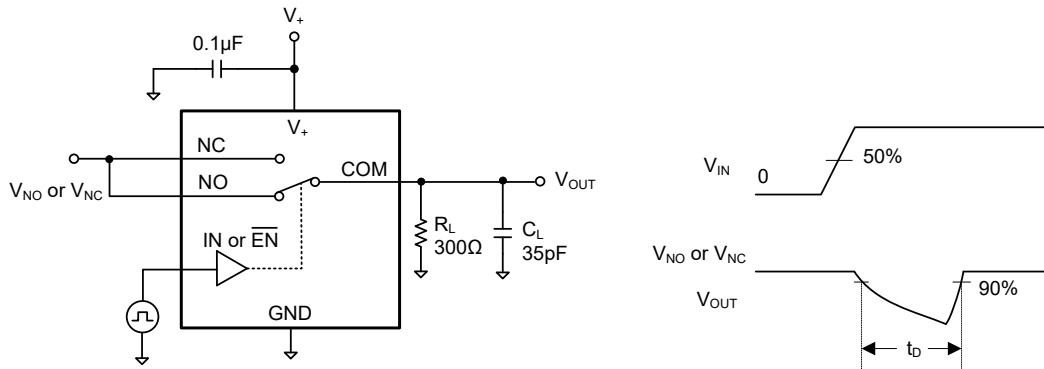
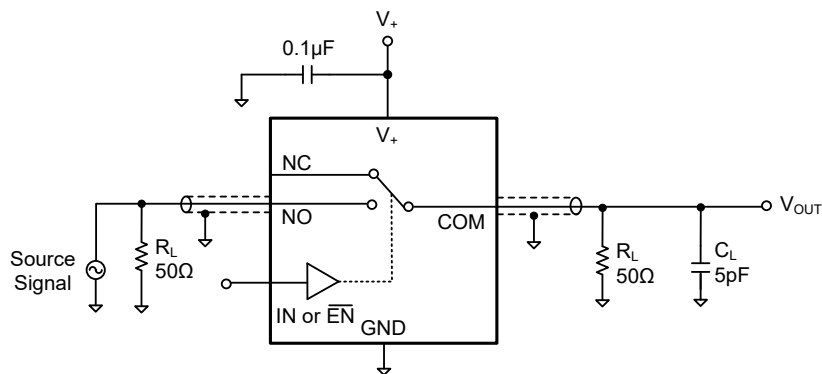


Test Circuit 2. Switching Times

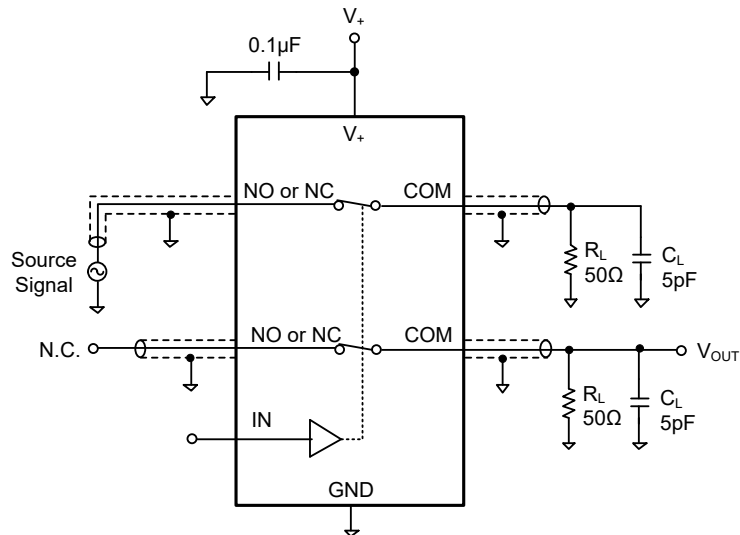


Test Circuit 3. Charge Injection

TEST CIRCUITS (continued)

Test Circuit 4. Break-Before-Make Time Delay (t_d)

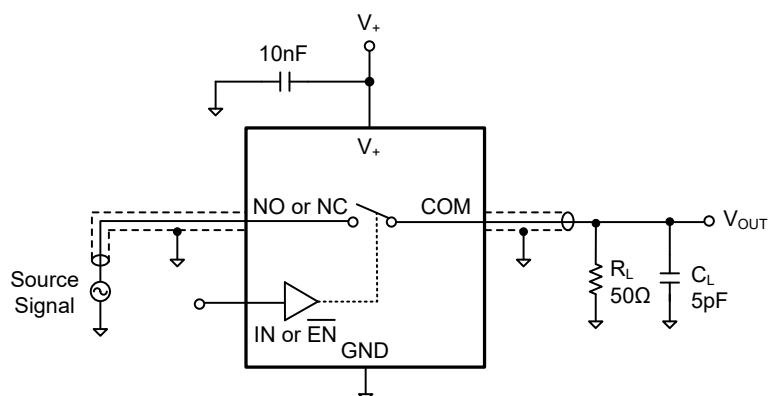
Test Circuit 5. Off Isolation



$$\text{Channel-to-Channel Crosstalk} = -20 \times \log \frac{V_{NO \text{ or } V_{NC}}}{V_{OUT}}$$

Test Circuit 6. Channel-to-Channel Crosstalk

TEST CIRCUITS (continued)



Test Circuit 7. -3dB Bandwidth

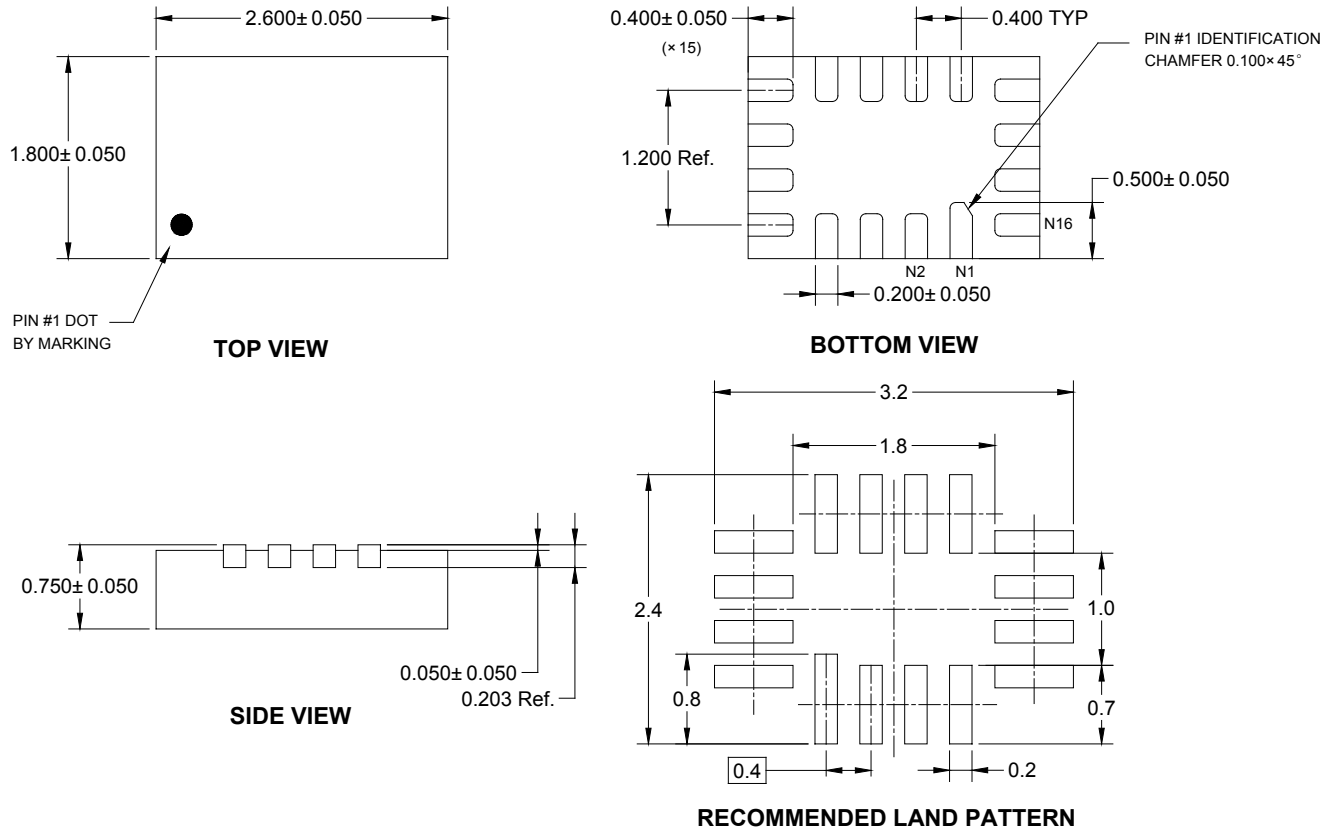
REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

MAY 2016 – REV.A.3 to REV.A.4	Page
Updated Package Outline Dimensions section	10
Updated Tape and Reel Information section	12
JANUARY 2013 – REV.A.2 to REV.A.3	Page
Updated Package Outline Dimensions section	10
Updated Tape and Reel Information section	11, 12
MAY 2011 – REV.A.1 to REV.A.2	Page
Updated package name.....	All
DECEMBER 2008 – REV.A to REV.A.1	Page
Updated typeset	All
Changes from Original (MAY 2008) to REV.A	Page
Changed from product preview to production data.....	All

PACKAGE OUTLINE DIMENSIONS

TQFN-2.6×1.8-16L

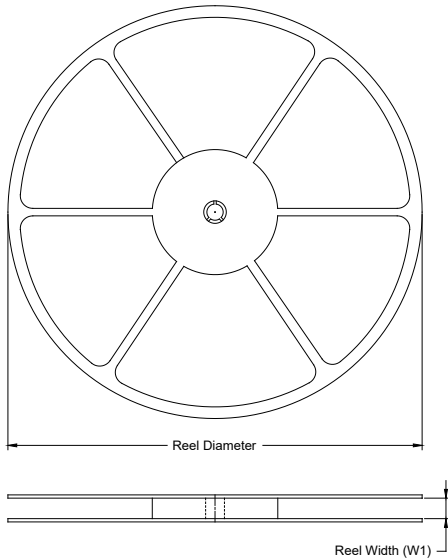


NOTE: All linear dimensions are in millimeters.

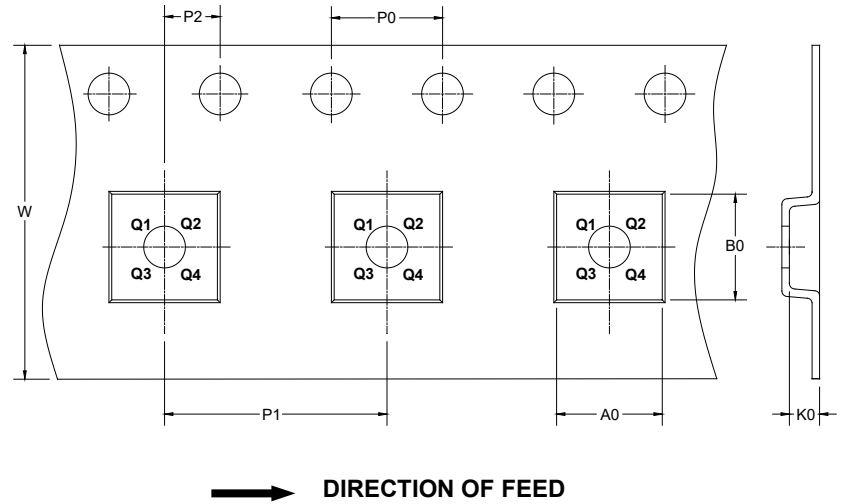
PACKAGE INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

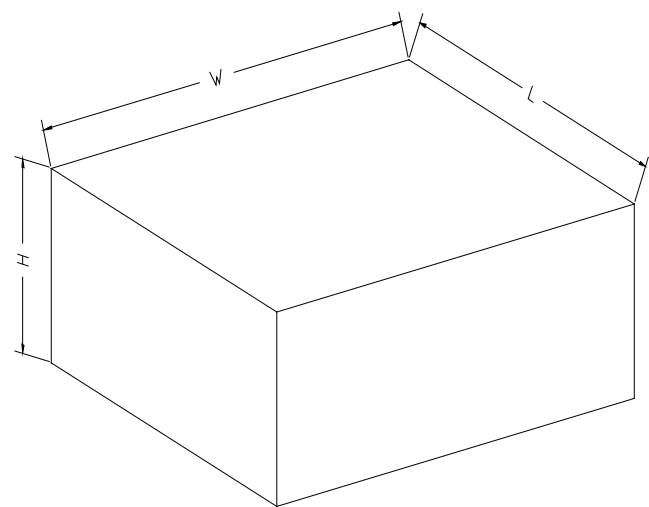
KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
TQFN-2.6×1.8-16L	7"	9.0	2.01	2.81	0.93	4.0	4.0	2.0	8.0	Q1

DD00001

PACKAGE INFORMATION

CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton
7" (Option)	368	227	224	8
7"	442	410	224	18

DD0002